Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10593424	RITTER ET AL.
Examiner	Art Unit
Hai Phan	2614

SEARCHED				
Class	Subclass	Date	Examiner	
381	381, 327, 110, 56, 57, 71.1, 92, 94.1	10/05/10	HP	

SEARCH NOTES			
Search Notes	Date	Examiner	
Inventor Search	10/05/10	HP	
EAST Search	10/05/10	HP	
Update Search	03/21/11	HP	
Update Search	09/24/11	HP	
Update Search	02/06/12	HP	

INTERFERENCE SEARCH				
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/HAI PHAN/ Primary Examiner.Art Unit 2614

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